

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/670,570	OHSHIMA ET AL.	
	Examiner	Art Unit	Page 1 of 1
Pawandeep S. Dhingra	2625		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0063887 A1	05-2002	White, Craig R.	358/1.15
*	B	US-2002/0196452 A1	12-2002	Komiya, Yoshiyuki	358/1.1
*	C	US-2003/0020951 A1	01-2003	Minowa et al.	358/1.15
*	D	US-6,629,753 B2	10-2003	Usui, Nobuaki	347/43
*	E	US-6,921,220 B2	07-2005	Aiyama, Kenji	400/76
*	F	US-6,973,514 B2	12-2005	Yamaguchi, Fumiyoishi	710/72
*	G	US-7,034,952 B2	04-2006	Okuda et al.	358/1.15
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	11-154068	06-1999	Japan	Ikegami Munemitsu	G06F 3/12
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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